

TOSHIBA Photocoupler

TLP721(D4)SERIES

Attachment: Specifications for VDE0884 option: (D4)

Types: TLP721, TLP721F

Type designations for ' option: (D4)', which are tested under VDE0884 requirements.

Ex.: TLP721 (D4-GR-LF4) D4: VDE0884 option
 GR: CTR rank
 LF4: lead bend

Note: Use TOSHIBA standard type number for safety standard application.



Ex. TLP721 (D4-GR-LF4) → TLP721

VDE0884 Isolation Characteristics

Description	Symbol	Rating	Unit
Application classification (DIN VDE0110 teil 1 / 01.89, table 1) for rated mains voltage ≤ 300 V _{rms} for rated mains voltage ≤ 600 V _{rms}		I-IV I-III	—
Climatic classification (DIN IEC68 teil 1 / 09.80)		40 / 100 / 21	—
Pollution degree (DIN VDE0110 teil 1 / 01.89)		2	—
Maximum operating insulation voltage	TLP721	630	V _{pk}
	TLP721F	890	
Input to output test voltage, method A V _{pr} = 1.5×V _{IORM} , type and sample test t _p = 60s, partial discharge < 5pC	TLP721	945	V _{pk}
	TLP721F	1335	
Input to output test voltage, method B V _{pr} = 1.875×V _{IORM} , 100% production test t _p = 1s, partial discharge < 5pC	TLP721	1180	V _{pk}
	TLP721F	1670	
Highest permissible overvoltage (transient overvoltage, t _{pr} = 10s)	V _{TR}	6000	V _{pk}
Safety limiting values (max. permissible ratings in case of fault, also refer to thermal derating curve) current (input current I _F , P _{si} = 0) power (output or total power dissipation) temperature	I _{si}	300	mA
	P _{si}	500	mW
	T _{si}	150	°C
Insulation resistance, V _{IO} = 500V, Ta = 25°C V _{IO} = 500V, Ta = T _{si}	R _{si}	≥10 ¹² ≥10 ⁹	Ω

- This data sheet refers to TLP721 (D4, M), TLP721F (D4, M) that previously has a white-resin mold and have been changed. When designing new products please use black mold-resin devices.

Insulation Related Specifications

		 7.62 mm pitch TLP721		 10.16 mm pitch TLP721F	
Minimum creepage distance	(*)	Cr	7.0 mm	8.0 mm	
Minimum clearance	(*)	Cl	7.0 mm	8.0 mm	
Minimum insulation thickness		ti	0.5 mm		
Comperative tracking index (DIN IEC112 / VDE0303, part 1)		CTI	175 (VDE0110 teil 1 / 01.89 group III a)		

((*) in accordance with DIN VDE0110 teil 1 / 01.89, table 2, & 4)

- (*1) If a printed circuit is incorporated, the creepage distance and clearance may be reduced below this value (e. g. at a standard distance between soldering eye centres of 7.5 mm). If this is not permissible, the user shall take suitable measures.
- (*2) This photocoupler is suitable for 'safe electrical isolation' only within the safety limit data. Maintenance of the safety data shall be ensured by means of protective circuits.

VDE Test sign: Marking on product for VDE0884

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Marking on packing for VDE0884



0884

Marking example:

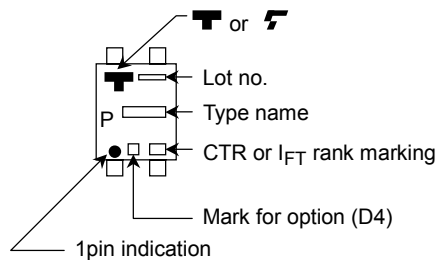


Figure 1 Partial discharge measurement procedure according to VDE0884 destructive test for qualification and sampling tests.

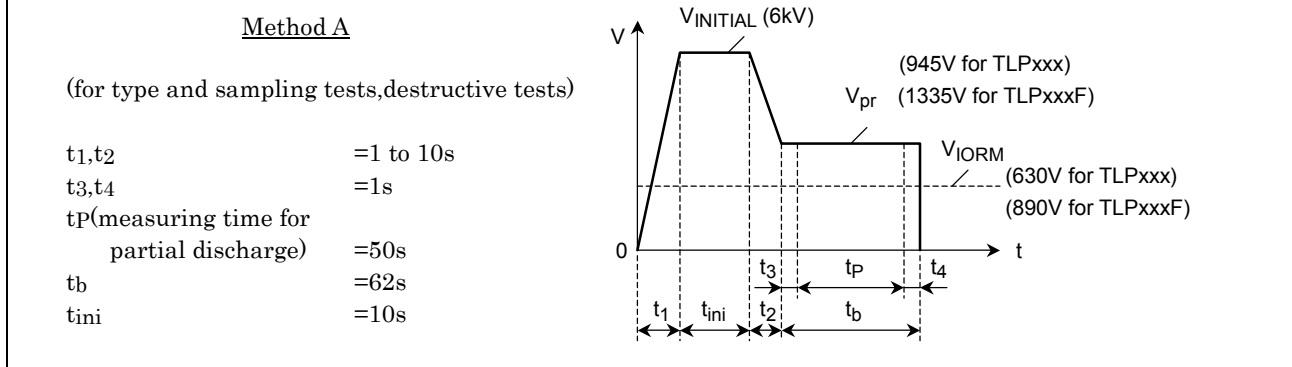


Figure 2 Partial discharge measurement procedure according to VDE0884 non-destructive test for 100% inspection.

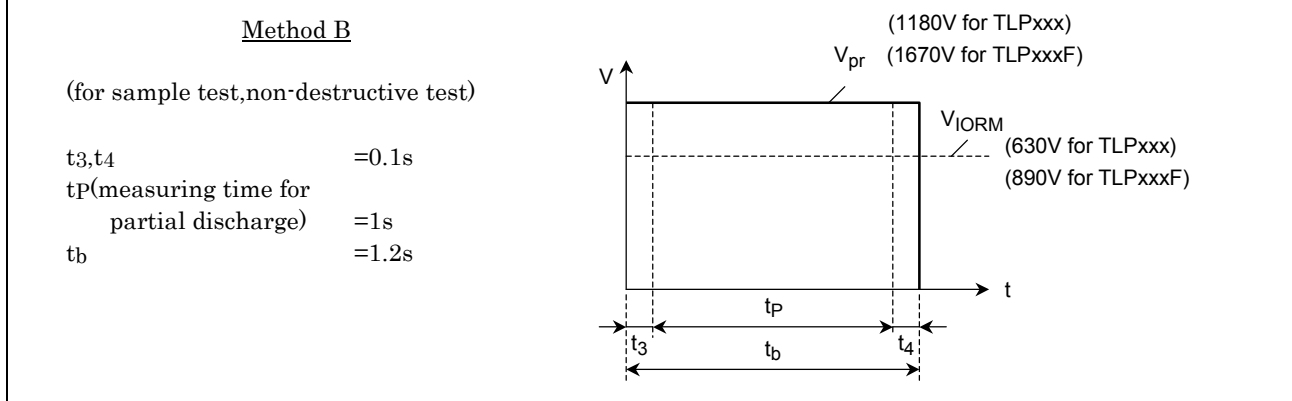
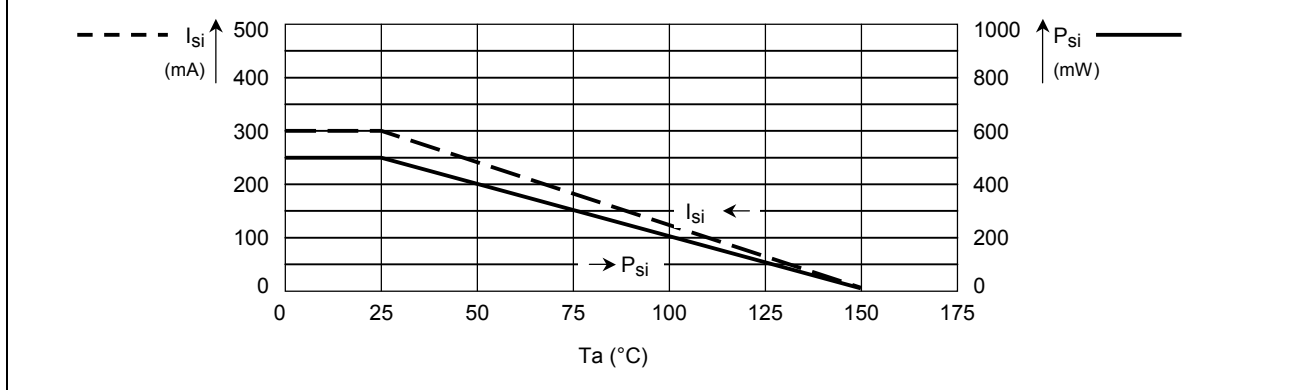


Figure 3 Dependency of maximum safety ratings on ambient temperature



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